

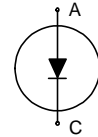
Fast switching diode

Features:

- 1700V technology, Emitter Controlled Diode 3th generation, 200 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient
- Qualified according to JEDEC for target applications

Recommended for:

- power modules



Applications:

- resonant applications, drives

Chip Type	V_R	$I_{Fn}^{(1)}$	Die Size	Package
SIDC130D170H	1700V	235A	16.3 x 8 mm ²	sawn on foil

⁽¹⁾ nominal forward current at $T_c = 100^\circ\text{C}$, not subject to production test - verified by design/characterisation

Mechanical Parameters

Die size		16.3 x 8	mm ²
Area total		130.4	
Anode pad size		14.28 x 5.98	
Thickness		200	µm
Wafer size		150	mm
Max. possible chips per wafer		100	
Passivation frontside		Photoimide	
Pad metal		3200 nm AlSiCu	
Backside metal		Ni Ag –system	
Die bond		Electrically conductive epoxy glue and soft solder	
Wire bond		Al, ≤500µm	
Reject ink dot size		∅ 0.65mm; max 1.2mm	
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month	
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month	



SIDC130D170H

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	$T_{vj} = 25\text{ °C}$	1700	V
Continuous forward current	I_F	$T_{vj} < 150\text{ °C}$	1 ¹⁾	A
Maximum repetitive forward current ²⁾	I_{FRM}	$T_{vj} < 150\text{ °C}$	470	
Junction temperature range	T_{vj}		-40...+175	°C
Operating junction temperature	T_{vj}		-40...+150	

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterisation

Static Characteristics (tested on wafer), $T_{vj} = 25\text{ °C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Reverse leakage current	I_R	$V_R = 1700\text{ V}$			11	μA
Cathode-Anode breakdown Voltage	V_{BR}	$I_R = 0.25\text{ mA}$	1700			V
Forward voltage drop	V_F	$I_F = 70.5\text{ A}$	1.15	1.35	1.55	V

Electrical Characteristics (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Forward voltage drop	V_F	$I_F = 235\text{ A}$		1.75	2.45	V
				1.8		

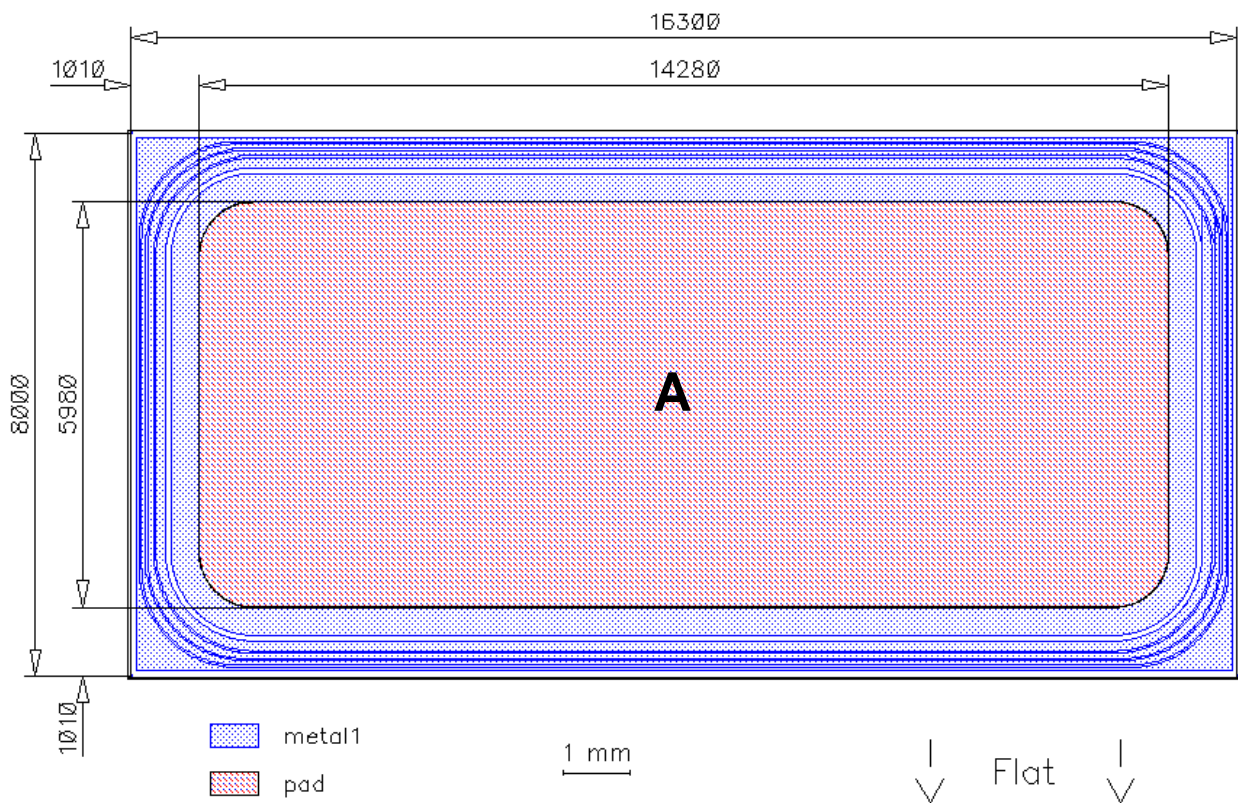
Further Electrical Characteristics

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FF1400R17IP4	Rev. 2.2
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Chip Drawing

Die-Size 16300 um x 8000 um



A: Anode pad



SIDC130D170H

Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

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